

Notice of References Cited	Application/Control No. 10/820,776		Applicant(s)/Patent Under Reexamination ST. DENIS ET AL.	
	Examiner PHUC H. TRAN		Art Unit 2616	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0151184	08-2004	Wang et al.	370/395.2
*	B	US-7,236,458	06-2007	Lee et al.	370/230
*	C	US-6,801,500	10-2004	Chandran, Kartik	370/230.1
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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